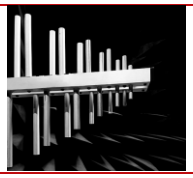
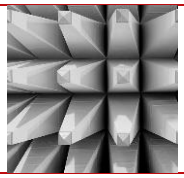

CETECOM™

CETECOM ICT Services
consulting - testing - certification

TEST REPORT

Test report no.: 1-9958/15-02-04

ilac-MRA DAkkS Deutsche Akkreditierungsstelle D-PL-12076-01-00

Testing laboratory

CETECOM ICT Services GmbH
Untertuerkheimer Strasse 6 – 10
66117 Saarbruecken / Germany
Phone: + 49 681 5 98 - 0
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e-mail: ict@cetecom.com

Accredited Testing Laboratory:
The testing laboratory (area of testing) is accredited according to DIN EN ISO/IEC 17025 (2005) by the Deutsche Akkreditierungsstelle GmbH (DAkkS)
The accreditation is valid for the scope of testing procedures as stated in the accreditation certificate with the registration number: D-PL-12076-01-00

Applicant

Sphinx Electronics GmbH &Co. KG
Tullastr. 3
79341 Kenzingen / GERMANY
Phone: +49 7 64 49 22 80
Fax: +49 76 44 92 28 90
Contact: Marco Bürgel
e-mail: marco.buergel@sphinx-electronics.de
Phone: +49 76 44 92 28 51

Manufacturer

Guangdong Be-Tech Security Systems Co, Ltd.
No 17, Keyuan 3 Road, Ronggui, Foshan
528306 Guangdong / CHINA

Test standard/s

47 CFR Part 15	Title 47 of the Code of Federal Regulations; Chapter I; Part 15 - Radio frequency devices
RSS - 210 Issue 8	Spectrum Management and Telecommunications Radio Standards Specification - Licence-exempt Radio Apparatus (All Frequency Bands): Category I Equipment
RSS - Gen Issue 4	Spectrum Management and Telecommunications Radio Standards Specifications - General Requirements and Information for the Certification of Radio Apparatus

For further applied test standards please refer to section 3 of this test report.

Test Item

Kind of test item:	**RFID door access** point
Model name:	**DT700**
FCC ID:	**TCN011**
IC:	**5103A-011**
Frequency:	13.56 MHz
Technology tested:	RFID
Antenna:	Integrated antenna
Power supply:	5.0 V to 6.4 V AC
Temperature range:	0.0°C to +40°C

This test report is electronically signed and valid without handwriting signature. For verification of the electronic signatures, the public keys can be requested at the testing laboratory.

Test report authorized:

cn=Andreas Luckenbill, o=CETECOM ICT Services GmbH, ou=LUC-111202, email=andreas.luckenbill@cetecom.com, c=DE
2015.10.28 07:58:51 +01'00'

Andreas Luckenbill
Lab Manager
Radio Communications & EMC

Test performed:

cn=Christoph Schneider, o=CETECOM ICT Services GmbH, ou=SND-120402, email=christoph.schneider@cetecom.com, c=DE
2015.10.21 08:32:32 +02'00'

Christoph Schneider
Testing Manager
Radio Communications & EMC

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2 General information

2.1 Notes and disclaimer

The test results of this test report relate exclusively to the test item specified in this test report. CETECOM ICT Services GmbH does not assume responsibility for any conclusions and generalizations drawn from the test results with regard to other specimens or samples of the type of the equipment represented by the test item.
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This test report is electronically signed and valid without handwritten signature. For verification of the electronic signatures, the public keys can be requested at the testing laboratory.

2.2 Application details

Date of receipt of order:	2015-05-28
Date of receipt of test item:	2015-09-17
Start of test:	2015-09-22
End of test:	2015-09-24
Person(s) present during the test:	-/-

3 Test standard/s

Test standard	Date	Test standard description
47 CFR Part 15		Title 47 of the Code of Federal Regulations; Chapter I; Part 15 - Radio frequency devices
RSS - 210 Issue 8	December 2010	Spectrum Management and Telecommunications Radio Standards Specification - Licence-exempt Radio Apparatus (All Frequency Bands): Category I Equipment
RSS - Gen Issue 4	November 2014	Spectrum Management and Telecommunications Radio Standards Specifications - General Requirements and Information for the Certification of Radio Apparatus

3.1 Measurement guidance

Guidance	Version	Description
ANSI C63.4-2014	-/-	American national standard for methods of measurement of radio-noise emissions from low-voltage electrical and electronic equipment in the range of 9 kHz to 40 GHz
ANSI C63.10-2013	-/-	American national standard of procedures for compliance testing of unlicensed wireless devices

4 Test environment

Temperature	:	T_{nom} T_{max} T_{min}	+22 °C during room temperature tests +55 °C during high temperature tests -20 °C during low temperature tests
Relative humidity content	:		55 %
Barometric pressure	:		not relevant for this kind of testing
Power supply	:	V_{nom} V_{max} V_{min}	6.0 V DC by Battery 6.9 V 5.1 V

5 Test item

5.1 General description

Kind of test item	:	RFID door access point
Type identification	:	DT700
PMN	:	DT700
HVIN	:	DT700-TRF
FVIN	:	-/-
HMN	:	-/-
S/N serial number	:	-/-
HW hardware status	:	1.3
Firmware status	:	9.0.0.15
Frequency band	:	13.56 MHz
Type of radio transmission Use of frequency spectrum	: :	Single carrier
Type of modulation	:	N0N
Number of channels	:	1
Antenna	:	Integrated antenna
Power supply	:	5.0 V to 6.4 V DC by Battery
Temperature range	:	0.0°C to +40°C

5.2 Additional information

The content of the following annexes is defined in the QA. It may be that not all of the listed annexes are necessary for this report, thus some values in between may be missing.

Test setup- and EUT-photos are included in test report: 1-9958/15-02-01_AnnexA
1-9958/15-02-01_AnnexB
1-9958/15-02-01_AnnexF

6 Test laboratories sub-contracted

None

7 Description of the test setup

Typically, the calibrations of the test apparatus are commissioned to and performed by an accredited calibration laboratory. The calibration intervals are determined in accordance with the DIN EN ISO/IEC 17025. In addition to the external calibrations, the laboratory executes comparison measurements with other calibrated test systems or effective verifications. Weekly chamber inspections and range calibrations are performed. Where possible, RF generating and signaling equipment as well as measuring receivers and analyzers are connected to an external high-precision 10 MHz reference (GPS-based or rubidium frequency standard).

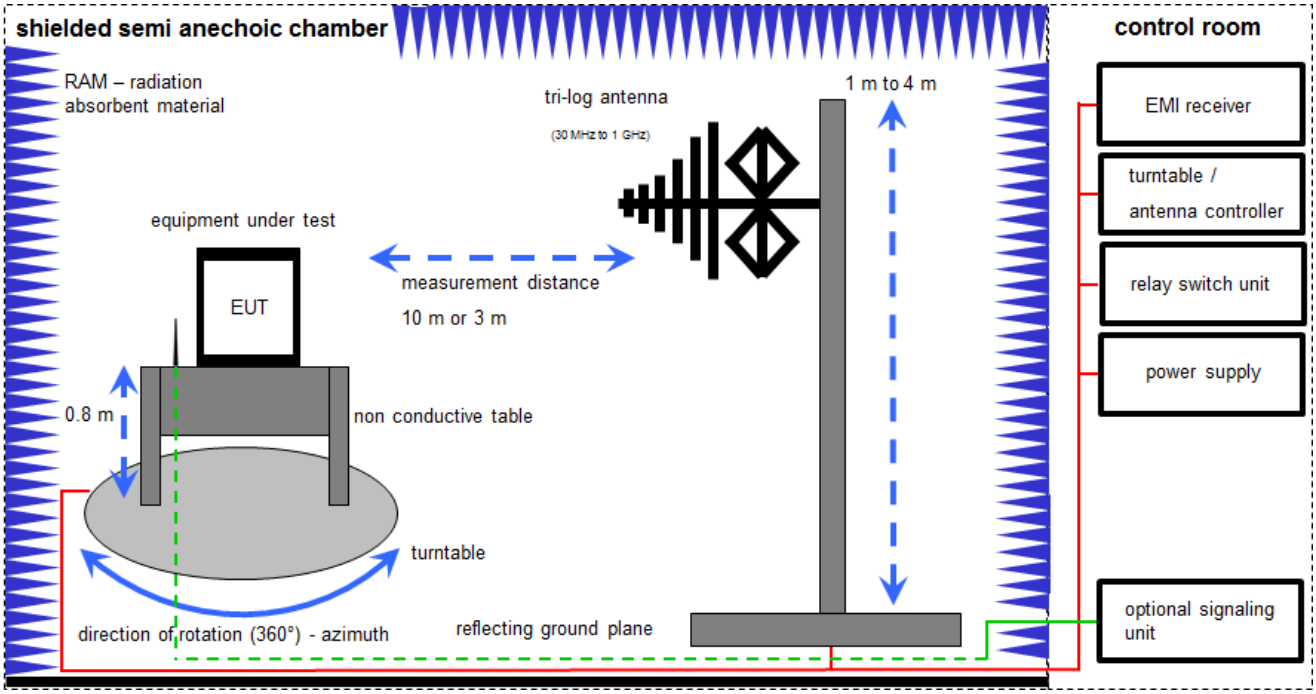
In order to simplify the identification of the equipment used at some special tests, some items of test equipment and ancillaries can be provided with an identifier or number in the equipment list below (Lab/Item).

Agenda: Kind of Calibration

k	calibration / calibrated	EK	limited calibration
ne	not required (k, ev, izw, zw not required)	zw	cyclical maintenance (external cyclical maintenance)
ev	periodic self verification	izw	internal cyclical maintenance
Ve	long-term stability recognized	g	blocked for accredited testing
vlkl!	Attention: extended calibration interval		
NK!	Attention: not calibrated	*)	next calibration ordered / currently in progress

7.1 Shielded semi anechoic chamber

The radiated measurements are performed in vertical and horizontal plane in the frequency range from 9 kHz to 1 GHz in semi-anechoic chambers. The EUT is positioned on a non-conductive support with a height of 0.80 m above a conductive ground plane that covers the whole chamber. The receiving antennas are confirmed with specifications ANSI C63. These antennas can be moved over the height range between 1.0 m and 4.0 m in order to search for maximum field strength emitted from EUT. The measurement distances between EUT and receiving antennas are indicated in the test setups for the various frequency ranges. For each measurement, the EUT is rotated in all three axes until the maximum field strength is received. The wanted and unwanted emissions are received by spectrum analyzers where the detector modes and resolution bandwidths over various frequency ranges are set according to requirement ANSI C63.



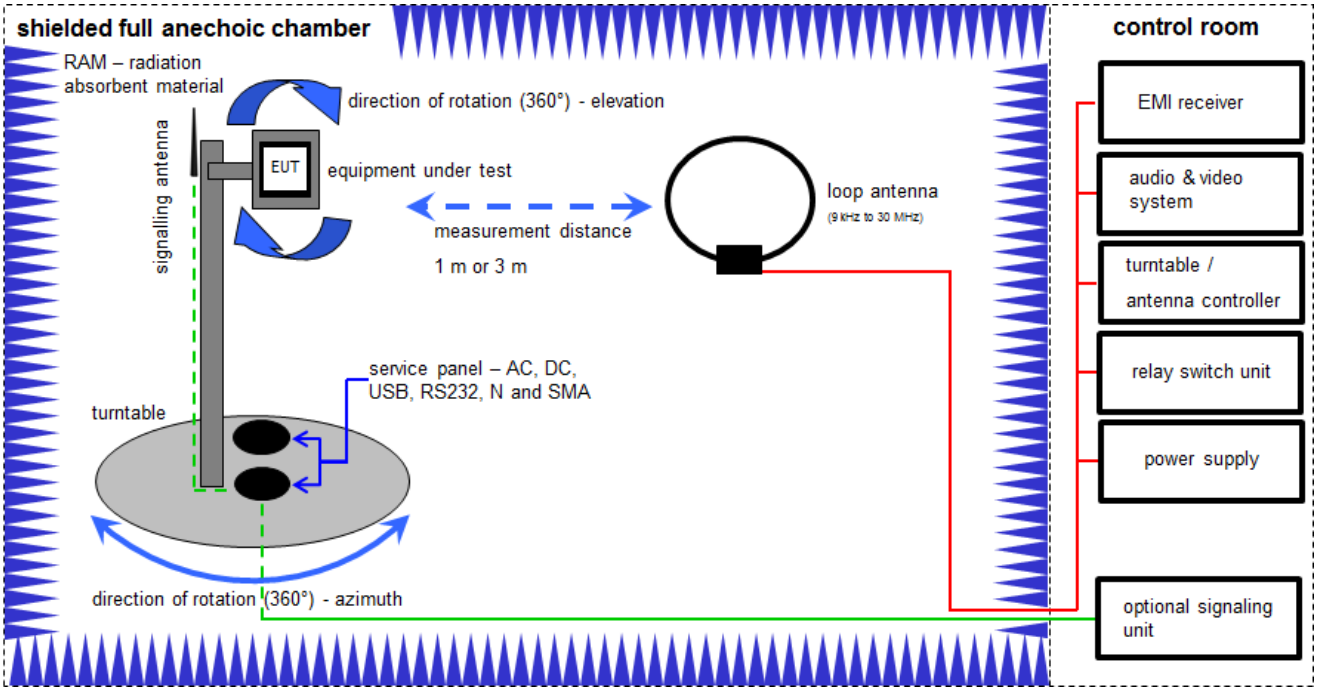
FS = UR + CL + AF
(FS-field strength; UR-voltage at the receiver; CL-loss of the cable; AF-antenna factor)

Example calculation:
FS [dBµV/m] = 12.35 [dBµV/m] + 1.90 [dB] + 16.80 [dB/m] = 31.05 [dBµV/m] (35.69 µV/m)

Equipment table:

No.	Lab / Item	Equipment	Type	Manufacturer	Serial No.	INV. No Cetecom	Kind of Calibration	Last Calibration	Next Calibration
1	A	Switch-Unit	3488A	HP	2719A14505	300000368	ev		
2	A	RF-Filter-section	85420E	HP	3427A00162	300002214	k	27.11.2006	
3	A	EMI Test Receiver	ESCI 3	R&S	100083	300003312	k	26.01.2015	26.01.2016
4	A	Antenna Tower	Model 2175	ETS-Lindgren	64762	300003745	izw		
5	A	Positioning Controller	Model 2090	ETS-Lindgren	64672	300003746	izw		
6	A	Turntable Interface-Box	Model 105637	ETS-Lindgren	44583	300003747	izw		
7	A	TRILOG Broadband Test-Antenna 30 MHz - 3 GHz	VULB9163	Schwarzbeck	295	300003787	k	22.04.2014	22.04.2016

7.2 Shielded fully anechoic chamber



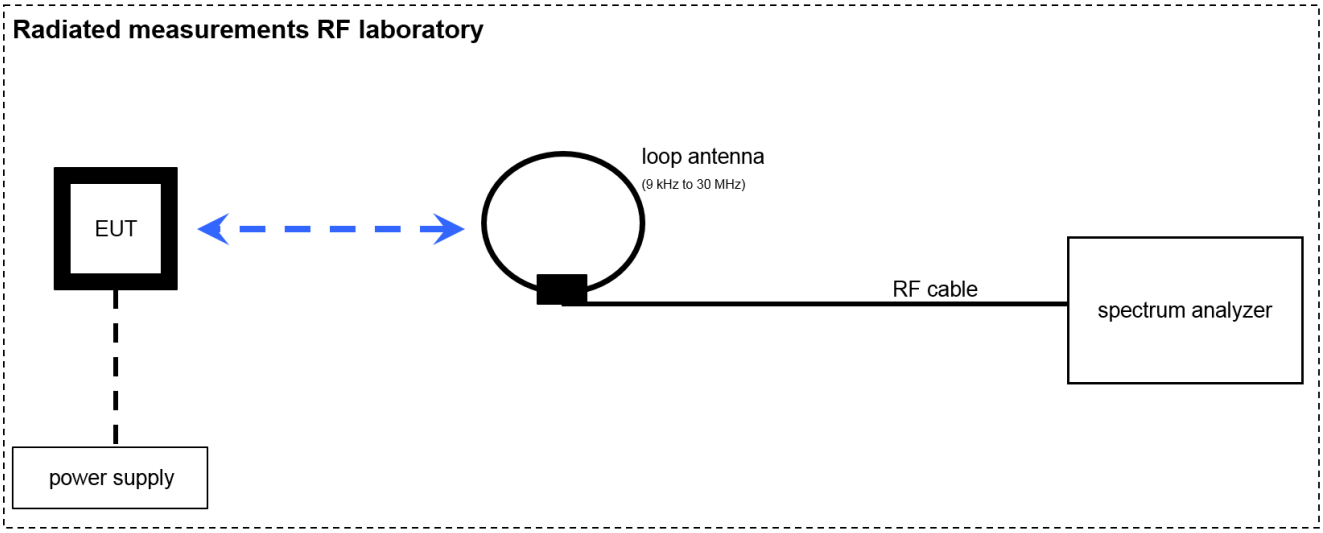
FS = UR + CA + AF
(FS-field strength; UR-voltage at the receiver; CA-loss of the signal path; AF-antenna factor)

Example calculation:
FS [dBµV/m] = 40.0 [dBµV/m] + (-35.8) [dB] + 32.9 [dB/m] = 37.1 [dBµV/m] (71.61 µV/m)

Equipment table:

No.	Lab / Item	Equipment	Type	Manufacturer	Serial No.	INV. No Cetecom	Kind of Calibration	Last Calibration	Next Calibration
1	A	Anechoic chamber	FAC 3/5m	MWB / TDK	87400/02	300000996	ev		
2	A	Switch / Control Unit	3488A	HP	*	300000199	ne		
3	A	Active Loop Antenna 10 kHz to 30 MHz	6502	EMCO/2	8905-2342	300000256	k	24.06.2015	24.06.2017
4	A	MXE EMI Receiver 20 Hz to 26,5 GHz	N9038A	Agilent Technologies	MY51210197	300004405	k	06.03.2015	06.03.2016
5	A	4U RF Switch Platform	L4491A	Agilent Technologies	MY50000037	300004509	ne		

7.3 Conducted measurements



Equipment table:

No.	Lab / Item	Equipment	Type	Manufacturer	Serial No.	INV. No Cetecom	Kind of Calibration	Last Calibration	Next Calibration
1	A	EMI Test Receiver 9 kHz - 3 GHz incl. Preselector	ESPI3	R&S	101713	300004059	k	23.01.2015	23.01.2016
2	A	Active Loop Antenna 10 kHz to 30 MHz	6502	EMCO/2	8905-2342	300000256	k	24.06.2015	24.06.2017
3	A	RF Cable BNC	RG58	Huber & Suhner		400001209	ev		

8 Measurement uncertainty

Measurement uncertainty	
Test case	**Uncertainty**
Occupied bandwidth	± 5 kHz
Field strength of the fundamental	± 3 dB
Field strength of the harmonics and spurious emissions below 30 MHz	± 3 dB
Field strength of the harmonics and spurious emissions 30 MHz to 1 GHz	± 3 dB
Frequency error	± 10 Hz

9 Sequence of testing

9.1 Sequence of testing 9 kHz to 30 MHz

Setup

- The equipment was set up to simulate a typical usage like descripted in the user manual or described by manufacturer.
- If the EUT is a tabletop system, a rotatable table with 1.5 m height is used.
- If the EUT is a floor standing device, it is placed on the ground.
- Auxiliary equipment and cables were positioned to simulate normal operation conditions as described in ANSI C 63.4.
- The AC power port of the EUT (if available) is connected to a power outlet below the turntable.
- The measurement distance is 3 meter (see ANSI C 63.4) – see each test details
- The EUT was set into operation.

Premeasurement

- The turntable rotates from 0° to 315° using 45° steps.
- The antenna height is 1.5 meter.
- At each turntable position the analyzer sweeps with peak detection to find the maximum of all emissions

Final measurement

- Identified emissions during the premeasurement the software maximizes by rotating the turntable position (0° to 360°) and by rotating the elevation axis (0° to 360°).
- The final measurement will be done in the position (turntable and elevation) causing the highest emissions with QPK (QPK / see ANSI C 63.4) detector
- The final levels, frequency, measuring time, bandwidth, turntable position, correction factor, margin to the limit and limit will be recorded. Also a plot with the graph of the premeasurement and the limit will be stored.

9.2 Sequence of testing 30 MHz to 1 GHz

Setup

- The equipment was set up to simulate a typical usage like descripted in the user manual or described by manufacturer.
- If the EUT is a tabletop system, a table with 0.8 m height is used, which is placed on the ground plane.
- If the EUT is a floor standing device, it is placed on the ground plane with insulation between both.
- Auxiliary equipment and cables were positioned to simulate normal operation conditions as described in ANSI C 63.4.
- The AC power port of the EUT (if available) is connected to a power outlet below the turntable.
- The measurement distance is 10 or 3 meter (see ANSI C 63.4) – see each test details
- The EUT was set into operation.
-

Premeasurement

- The turntable rotates from 0° to 315° using 45° steps.
- The antenna is polarized vertical and horizontal.
- The antenna height changes from 1 to 3 meter.
- At each turntable position, antenna polarization and height the analyzer sweeps three times in peak to find the maximum of all emissions
-

Final measurement

- The final measurement will be performed with minimum the six highest peaks.
- According to the maximum antenna and turntable positions of premeasurement the software maximize the peaks by changing turntable position (± 45°) and antenna movement between 1 and 4 meter.
- The final measurement will be done with QP (Quasi-Peak / see ANSI C 63.4) detector with an EMI receiver
- The final levels, frequency, measuring time, bandwidth, antenna height, antenna polarization, turntable angle, correction factor, margin to the limit and limit will be recorded. Also a plot with the graph of the premeasurement with marked maximum final measurements and the limit will be stored.

10 Summary of measurement results

☒	No deviations from the technical specifications were ascertained
☐	There were deviations from the technical specifications ascertained
☐	This test report is only a partial test report. The content and verdict of the performed test cases are listed below.

TC Identifier	Description	Verdict	Date	Remark
RF-Testing	CFR Part 15 RSS 210 Issue 8 RSS Gen Issue 4	See table!	2015-10-21	-/-

Test specification clause	Test case	Temperature conditions	Power source conditions	C	NC	NA	NP	Remark
RSS Gen Issue 4	Occupied bandwidth	Nominal	Nominal	☐	☐	☐	☐	-/-
§ 15.225 (a)	Field strength of the fundamental	Nominal	Nominal	☒	☐	☐	☐	-/-
§ 15.209 & § 15.225 (b-d)	Field strength of the harmonics and spurious	Nominal	Nominal	☒	☐	☐	☐	-/-
§ 15.109	Receiver spurious emissions and cabinet radiations	Nominal	Nominal	☐	☐	☒	☐	no decdicated RX mode
§15.107 §15.207	Conducted limits	Nominal	Nominal	☐	☐	☒	☐	battery powered only
§ 15.225 (a)	Frequency tolerance	Normal & extreme conditions	Normal & extreme conditions	☒	☐	☐	☐	-/-

Note: C = compliant; NC = not compliant; NA = Not Applicable; NP = Not Performed

11 Additional comments

Reference documents: None

Special test descriptions: None

Configuration descriptions: None

12 Measurement results

12.1 Occupied bandwidth

Measurement:

The emission bandwidth (x dB) is defined as the frequency range between two points, one above and one below the carrier frequency, at which the spectral density of the emission is attenuated x dB below the maximum in-band spectral density of the modulated signal.

Measurement parameters	
Detector:	Peak
Resolution bandwidth:	1 % – 5 % of the occupied bandwidth
Video bandwidth:	≥ 3x RBW
Trace mode:	Max hold
Analyser function:	99 % power function
Used equipment:	See chapter 7.3 A
Measurement uncertainty:	See chapter 8

Limit:

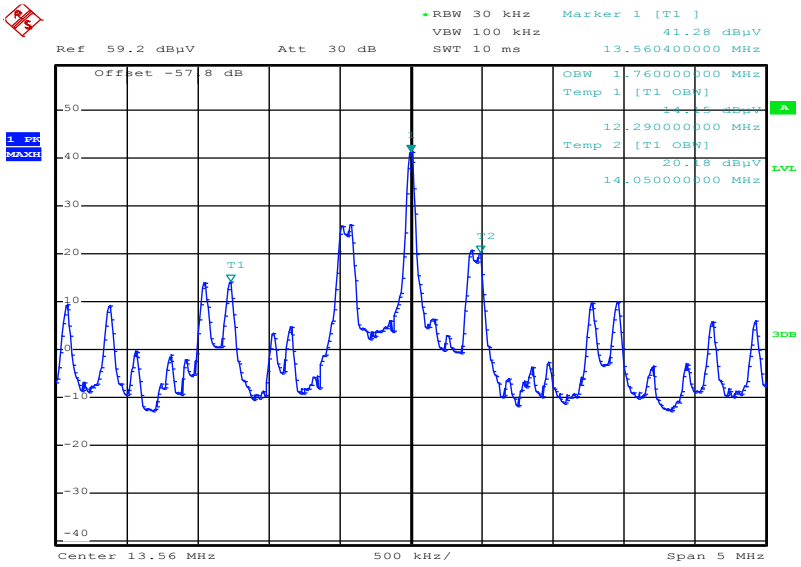
IC
for RSP-100 test report coversheet only

Result:

99% emission bandwidth
1760 kHz

Plot:

Plot 1: 99 % emission bandwidth



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12.2 Field strength of the fundamental

Measurement:

The maximum detected field strength for the carrier signal.

Measurement parameters	
Detector:	Quasi peak / peak (worst case)
Resolution bandwidth:	120 kHz
Video bandwidth:	≥ 3x RBW
Trace mode:	Max hold
Used equipment:	See chapter 7.2 A
Measurement uncertainty:	See chapter 8

Limit:

FCC & IC		
Frequency (MHz)	Field strength (µV/m)	Measurement distance (m)
13.553 to 13.567	15,848 (84 dBµV/m)	30

Recalculation:

According to ANSI C63.10		
Frequency	Formula	Correction value
13.56 MHz	$FS_{limit} = FS_{max} - 40\log\left(\frac{d_{nearfield}}{d_{measure}}\right) - 20\log\left(\frac{d_{limit}}{d_{nearfield}}\right)$	-21.39

ANSI C63.10-2013, American National Standard for Testing Unlicensed Wireless Devices

Result:

Field strength of the fundamental		
Frequency	13.56 MHz	
Distance	@ 3 m	@ 30 m
Measured / calculated value	51.2 dBµV/m	29.81 dBµV/m

12.3 Field strength of the harmonics and spurious

Measurement:

The maximum detected field strength for the harmonics and spurious.

Measurement parameters	
Detector:	Quasi peak / average or peak (worst case – pre-scan)
Resolution bandwidth:	F < 150 kHz: 200 Hz 150 kHz < F < 30 MHz: 9 kHz 30 MHz < F < 1 GHz: 120 kHz
Video bandwidth:	F < 150 kHz: 1 kHz 150 kHz < F < 30 MHz: 100 kHz 30 MHz < F < 1 GHz: 300 kHz
Trace mode:	Max hold
Used equipment:	See chapter 7.1 A / 7.2 A / 7.3 A
Measurement uncertainty:	See chapter 8

Limit:

FCC & IC		
Frequency (MHz)	Field strength (dBµV/m)	Measurement distance (m)
0.009 – 0.490	2400/F(kHz)	300
0.490 – 1.705	24000/F(kHz)	30
1.705 – 30	30 (29.5 dBµV/m)	30
30 – 88	100 (40 dBµV/m)	3
88 – 216	150 (43.5 dBµV/m)	3
216 – 960	200 (46 dBµV/m)	3

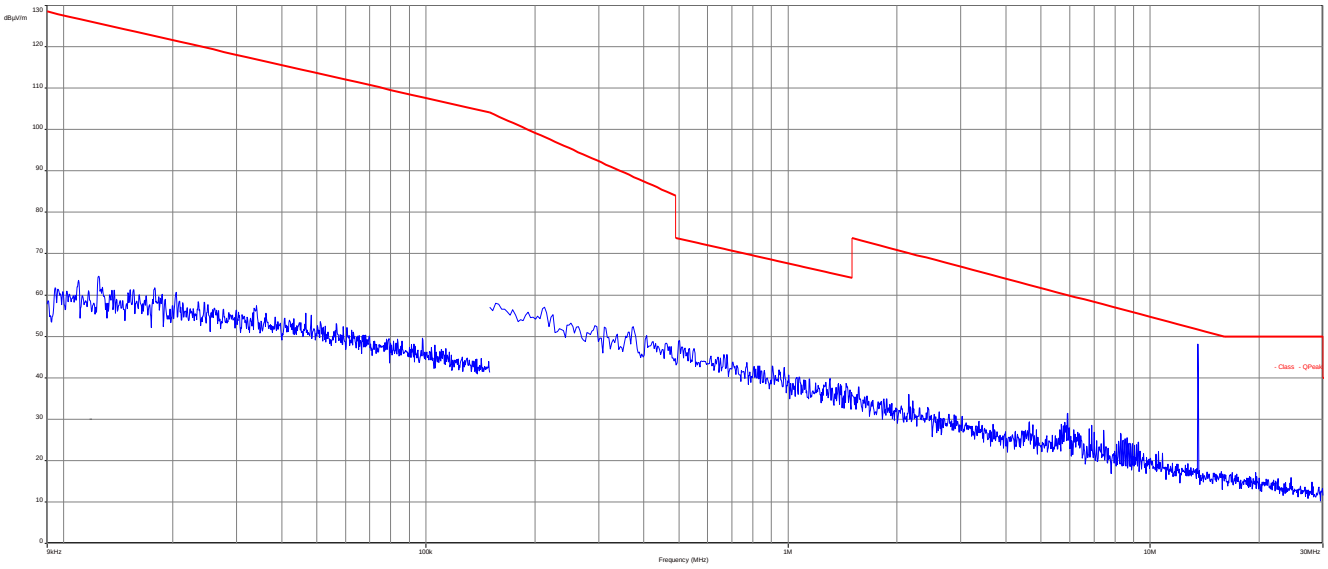
Note: For a reduced measurement distance, please take a look at the limit line and the ANSI C63.10-2013 sub clause 6.4 radiated emissions from unlicensed wireless devices below 30 MHz.

Result:

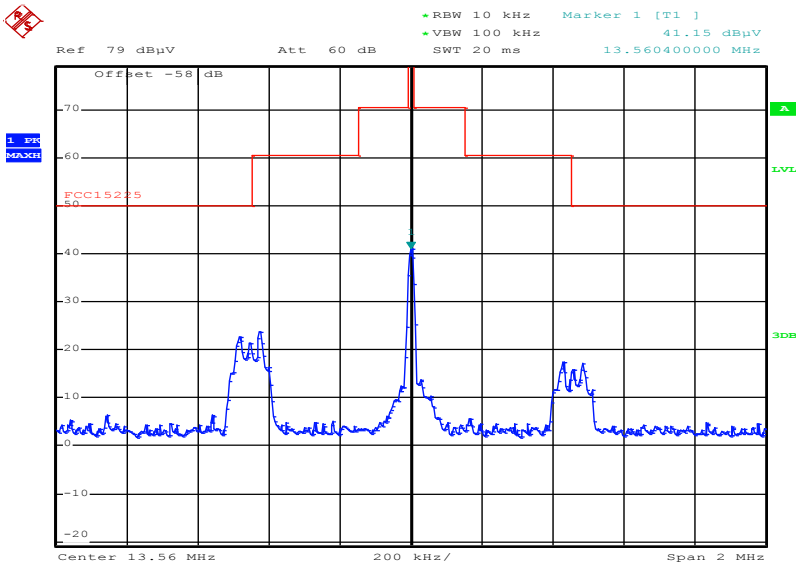
Detected emissions			
Frequency (MHz)	Detector	Resolution bandwidth (kHz)	Detected value
See result table below the 30 MHz to 1 GHz plot.			

Plots:

Plot 1: 9 kHz – 30 MHz, magnetic emissions



Plot 2: Spectrum mask (the limits are recalculated according to the ANSI C63.10-2013 sub clause 6.4)



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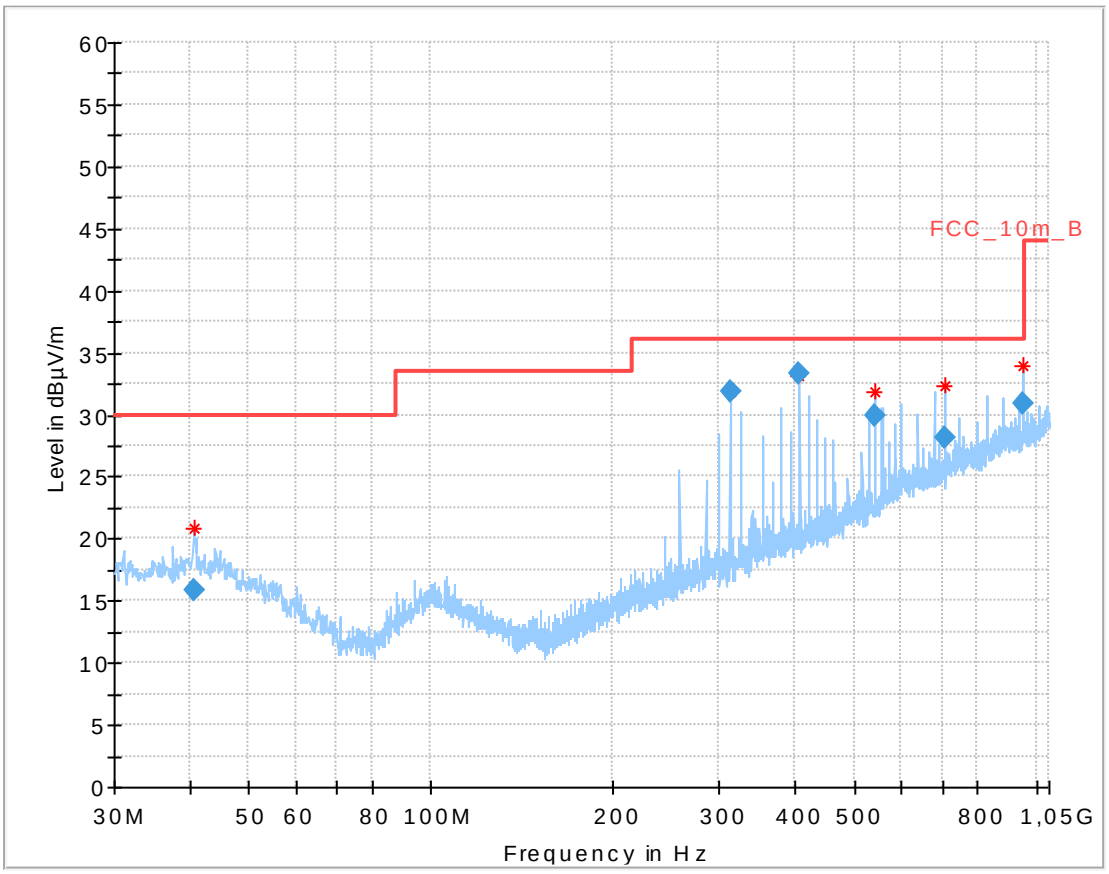
Plot 3: 30 MHz – 1 GHz, vertical and horizontal polarisation



Final_Result

Frequency (MHz)	QuasiPeak (dBµV/m)	Limit (dBµV/m)	Margin (dB)	Meas. Time (ms)	Bandwidth (kHz)	Height (cm)	Pol	Azimuth (deg)	Corr. (dB)
40.650600	15.91	30.00	14.09	1000.0	120.000	106.0	V	97	14.0
311.893650	31.78	36.00	4.22	1000.0	120.000	272.0	H	297	14.8
406.820100	33.30	36.00	2.70	1000.0	120.000	103.0	H	32	17.0
542.425650	29.93	36.00	6.07	1000.0	120.000	101.0	H	28	19.2
705.133650	28.06	36.00	7.94	1000.0	120.000	274.0	H	97	21.6
949.258200	30.85	36.00	5.15	1000.0	120.000	100.0	H	167	24.3

12.4 Frequency error

Measurement:

The maximum detected field strength for the spurious.

Measurement parameters	
Detector:	Peak detector
Resolution bandwidth:	10 Hz / 100 Hz
Video bandwidth:	> RBW
Trace mode:	Max hold
Used equipment:	See chapter 7.3 A
Measurement uncertainty:	See chapter 8

Limit:

FCC
The frequency tolerance of the carrier signal shall be maintained within +/- 0.01% of the operating frequency over a temperature variation of -20 degrees to +50 degrees C at normal supply voltage, and for a variation in the primary supply voltage from 85% to 115% of the rated supply voltage at a temperature of 20 degrees C. (±1.356 kHz)

Result: Temperature variation

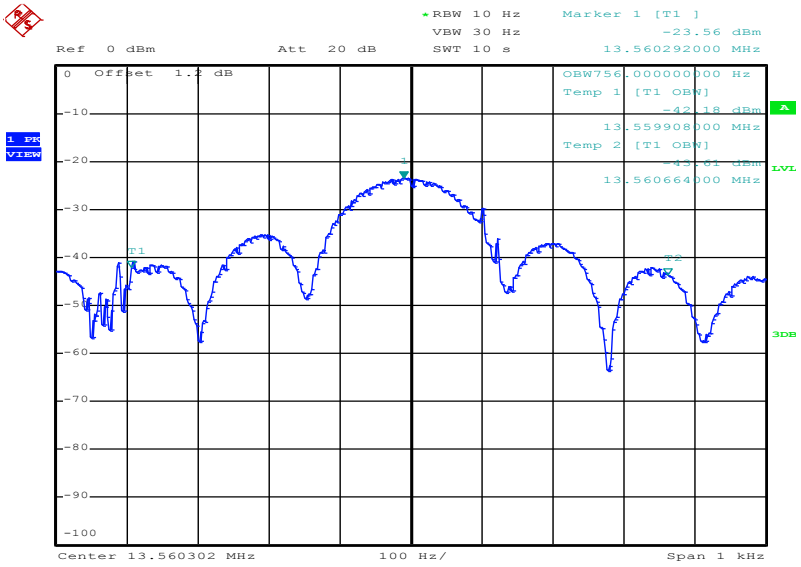
Frequency tolerance		
Measured frequency (MHz)	Conditions	Result
13.560348	-20 °C & 100% voltage	compliant
13.560343	-10 °C & 100% voltage	compliant
13.560368	0 °C & 100% voltage	compliant
13.560347	+10 °C & 100% voltage	compliant
13.560279	+20 °C & 100% voltage	compliant
13.560272	+30 °C & 100% voltage	compliant
13.560203	+40 °C & 100% voltage	compliant
13.560354	+50 °C & 100% voltage	compliant
13.560286	+55 °C & 100% voltage	compliant

Result: Voltage variation

Frequency tolerance		
Measured frequency (MHz)	Temperature	Result
13.560302	+20 °C & 85% voltage	compliant
13.560302	+20 °C & 100% voltage	compliant
13.560300	+20 °C & 115% voltage	compliant

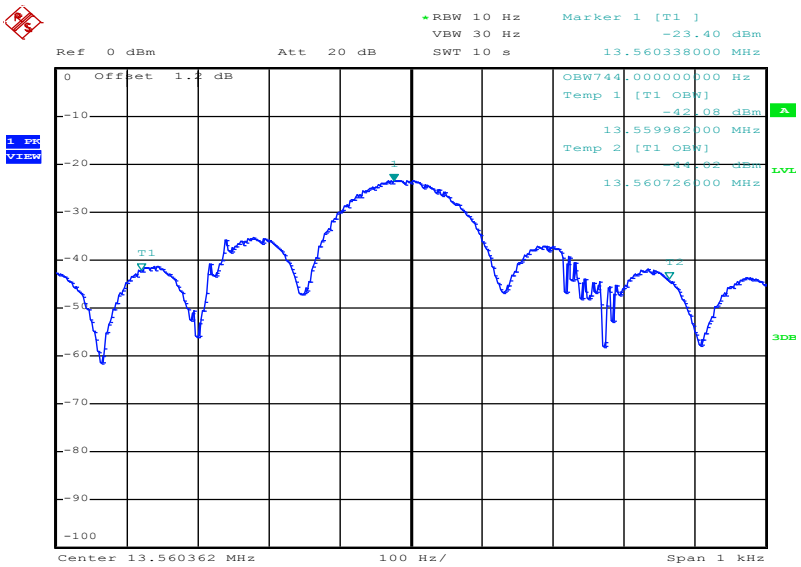
Plots:

Plot 1: 100% voltage; 55°C



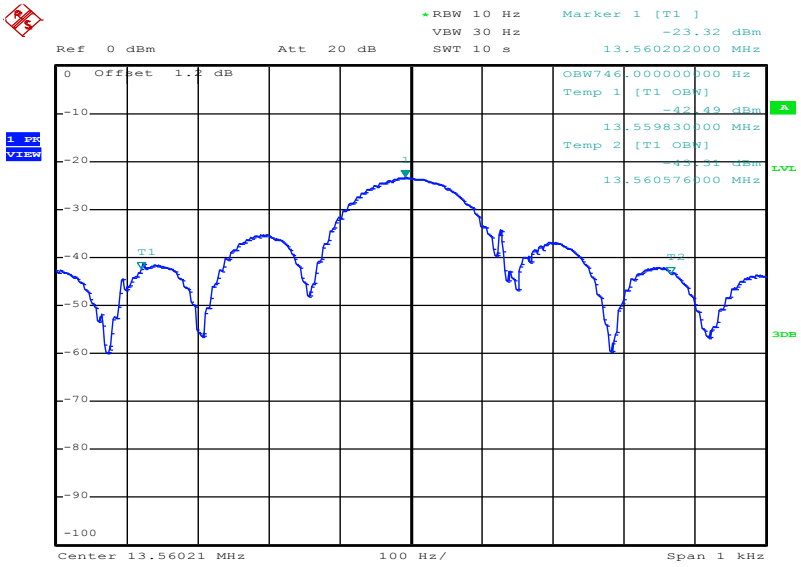
Date: 15.OCT.2015 14:14:01

Plot 2: 100% voltage; 50°C



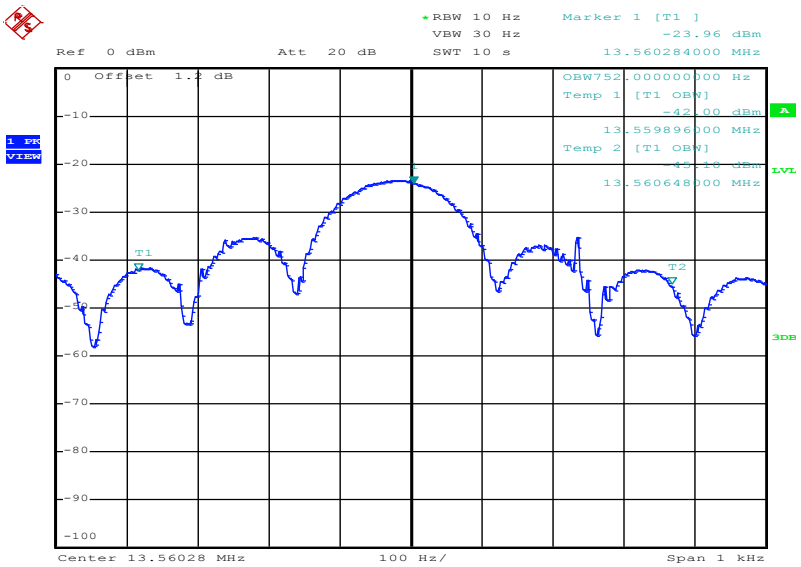
Date: 15.OCT.2015 14:08:23

Plot 3: 100% voltage; 40°C



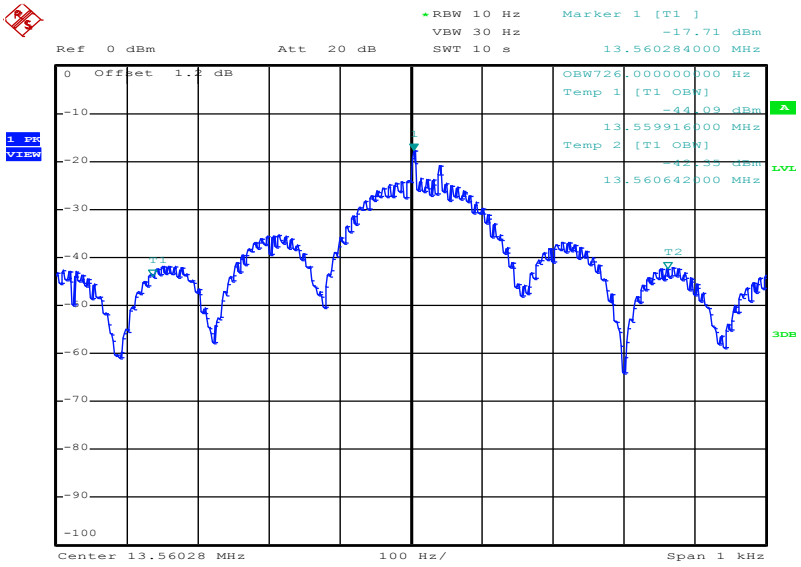
Date: 15.OCT.2015 13:52:53

Plot 4: 100% voltage; 30°C



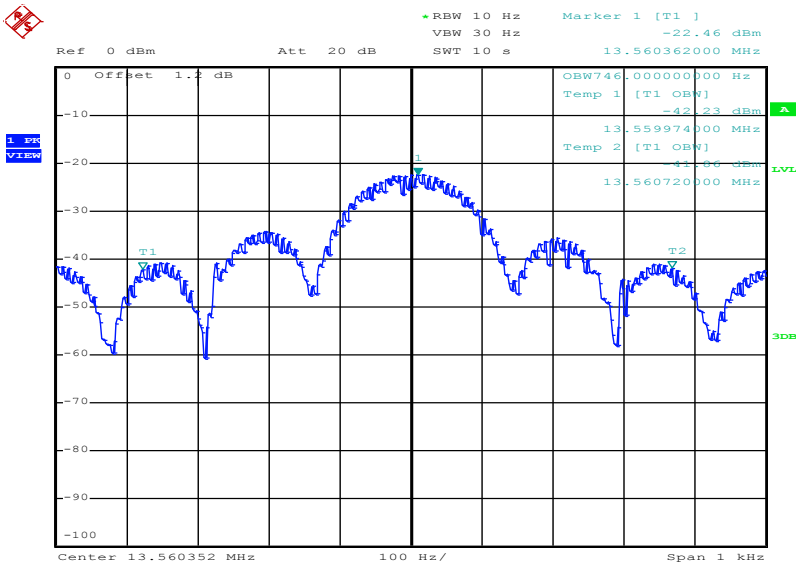
Date: 15.OCT.2015 13:49:07

Plot 5: 100% voltage; 20°C



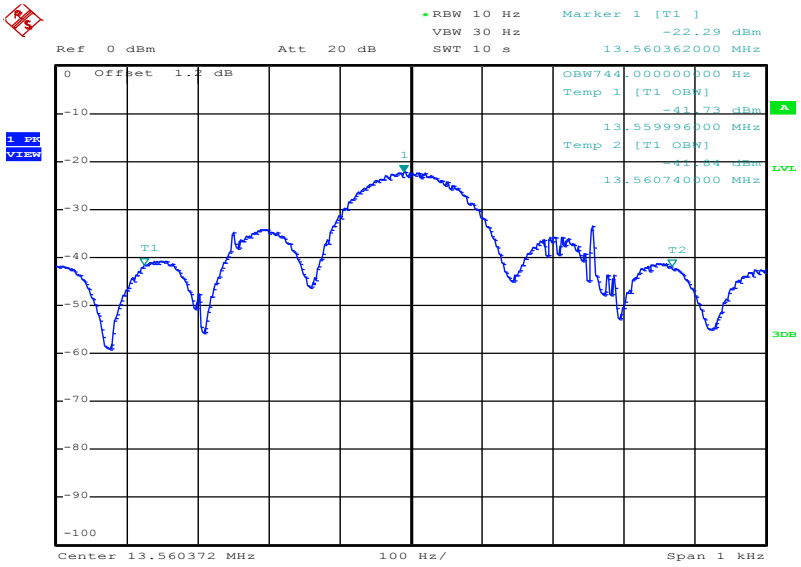
Date: 15.OCT.2015 13:41:19

Plot 6: 100% voltage; 10°C



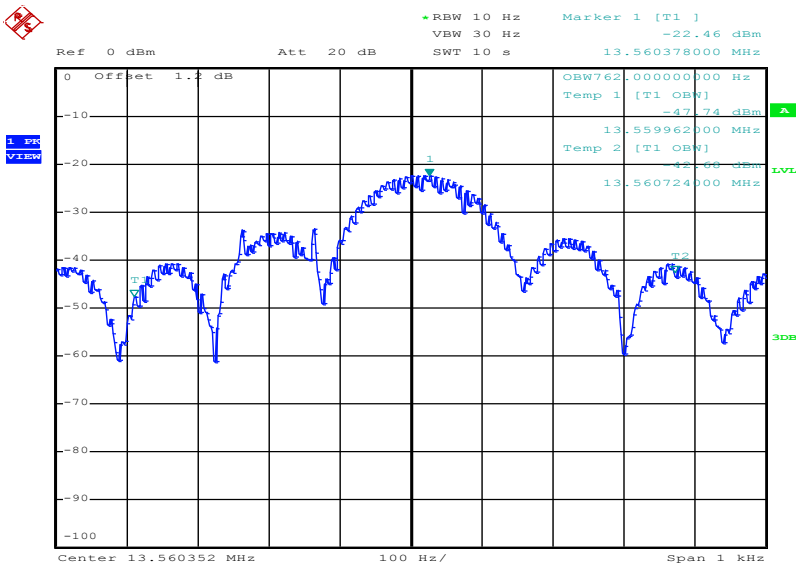
Date: 15.OCT.2015 15:01:59

Plot 7: 100 % voltage; 0°C



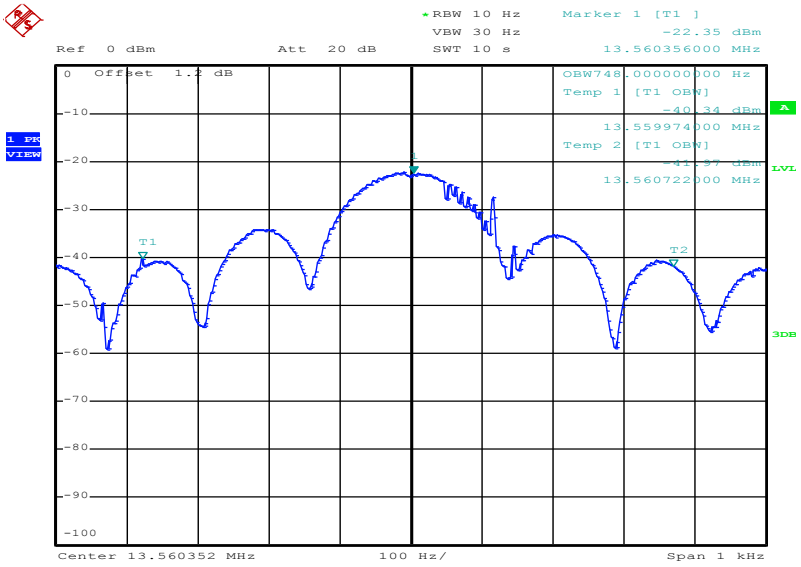
Date: 15.OCT.2015 14:55:00

Plot 8: 100 % voltage; -10°C



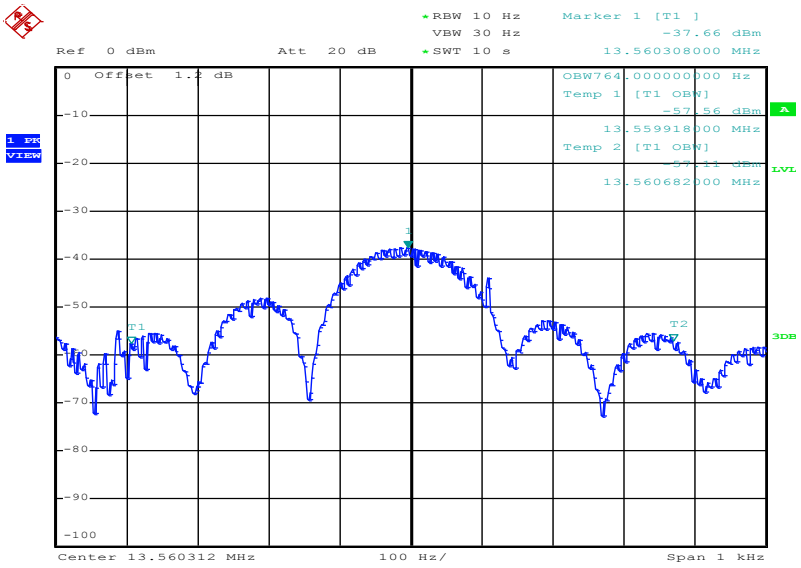
Date: 15.OCT.2015 14:47:23

Plot 9: 100 % voltage; -20°C



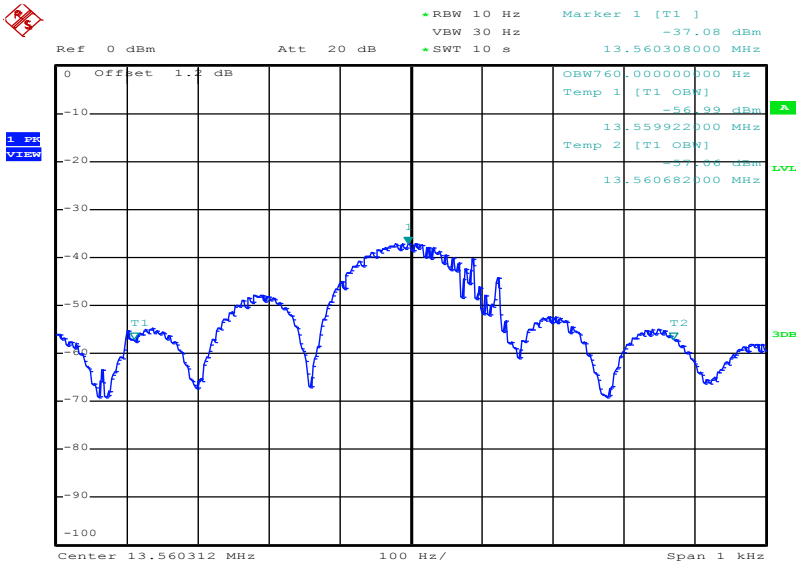
Date: 15.OCT.2015 14:39:25

Plot 10: 115 % voltage; 20°C



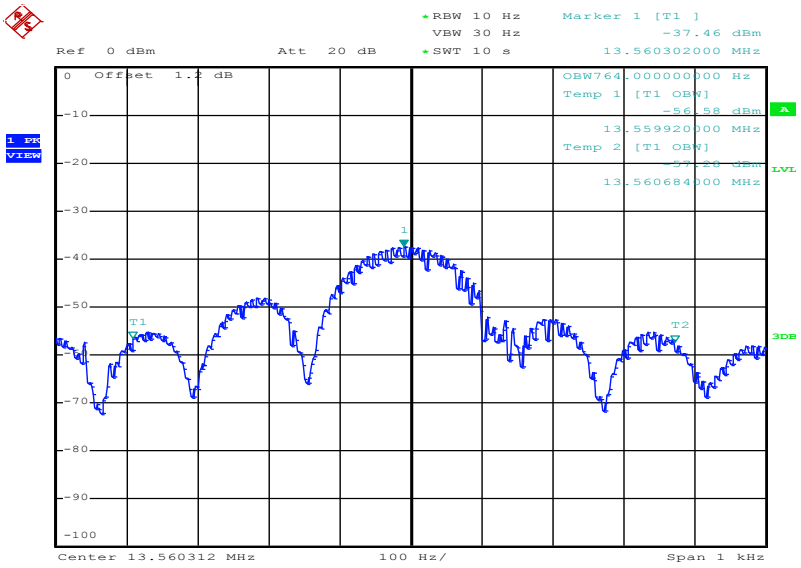
Date: 16.OCT.2015 07:31:22

Plot 11: 100 % voltage; 20°C



Date: 16.OCT.2015 07:29:30

Plot 12: 85 % voltage; 20°C



Date: 16.OCT.2015 07:32:59

13 Observations

No observations except those reported with the single test cases have been made.

Annex A Document history

Version	Applied changes	Date of release
	Initial release	2015-10-21

Annex B Further information

Glossary

AVG	-	Average
DUT	-	Device under test
EMC	-	Electromagnetic Compatibility
EN	-	European Standard
EUT	-	Equipment under test
ETSI	-	European Telecommunications Standard Institute
FCC	-	Federal Communication Commission
FCC ID	-	Company Identifier at FCC
HW	-	Hardware
IC	-	Industry Canada
Inv. No.	-	Inventory number
N/A	-	Not applicable
PP	-	Positive peak
QP	-	Quasi peak
S/N	-	Serial number
SW	-	Software
PMN		Product marketing name
HMN		Host marketing name
HVIN		Hardware version identification number
FVIN		Firmware version identification number

Annex C Accreditation Certificate

Front side of certificate

DAkkS Deutsche Akkreditierungsstelle

Deutsche Akkreditierungsstelle GmbH

Beliehene gemäß § 8 Absatz 1 AkkStelleG i.V.m. § 1 Absatz 1 AkkStelleGBV
Unterzeichnerin der Multilateralen Abkommen
von EA, ILAC und IAF zur gegenseitigen Anerkennung

Akkreditierung

Die Deutsche Akkreditierungsstelle GmbH bestätigt hiermit, dass das Prüflaboratorium

CETECOM ICT Services GmbH
Untertürkheimer Straße 6-10, 66117 Saarbrücken

die Kompetenz nach DIN EN ISO/IEC 17025:2005 besitzt, Prüfungen in folgenden Bereichen durchzuführen:

Drahtgebundene Kommunikation einschließlich xDSL
VoIP und DECT
Akustik
Funk einschließlich WLAN
Short Range Devices (SRD)
RFID
WiMax und Richtfunk
Mobilfunk (GSM / DCS, Over the Air (OTA) Performance)
Elektromagnetische Verträglichkeit (EMV) einschließlich Automotive
Produktsicherheit
SAR und Hearing Aid Compatibility (HAC)
Umweltsimulation
Smart Card Terminals
Bluetooth
Wi-Fi- Services

Die Akkreditierungsurkunde gilt nur in Verbindung mit dem Bescheid vom 07.03.2014 mit der Akkreditierungsnummer D-PL-12076-01 und ist gültig 17.01.2018. Sie besteht aus diesem Deckblatt, der Rückseite des Deckblatts und der folgenden Anlage mit insgesamt 77 Seiten.

Registrierungsnummer der Urkunde: **D-PL-12076-01-00**

Frankfurt am Main, 07.03.2014

Im Auftrag Dipl.-Ing. (FH) Ralf Egner
Abteilungsleiter

Back side of certificate

Deutsche Akkreditierungsstelle GmbH

Standort Berlin	Standort Frankfurt am Main	Standort Braunschweig
Spittelmarkt 10	Gartenstraße 6	Bundesallee 100
10117 Berlin	60594 Frankfurt am Main	38116 Braunschweig

Die auszugsweise Veröffentlichung der Akkreditierungsurkunde bedarf der vorherigen schriftlichen Zustimmung der Deutsche Akkreditierungsstelle GmbH (DAkkS). Ausgenommen davon ist die separate Weiterverbreitung des Deckblattes durch die umseitig genannte Konformitätsbewertungsstelle in unveränderter Form.

Es darf nicht der Anschein erweckt werden, dass sich die Akkreditierung auch auf Bereiche erstreckt, die über den durch die DAkkS bestätigten Akkreditierungsbereich hinausgehen.

Die Akkreditierung erfolgte gemäß des Gesetzes über die Akkreditierungsstelle (AkkStelleG) vom 31. Juli 2009 (BGBl. I S. 2625) sowie der Verordnung (EG) Nr. 765/2008 des Europäischen Parlaments und des Rates vom 9. Juli 2008 über die Vorschriften für die Akkreditierung und Marktüberwachung im Zusammenhang mit der Vermarktung von Produkten (Abl. L 218 vom 9. Juli 2008, S. 30).
Die DAkkS ist Unterzeichnerin der Multilateralen Abkommen zur gegenseitigen Anerkennung der European co-operation for Accreditation (EA), des International Accreditation Forum (IAF) und der International Laboratory Accreditation Cooperation (ILAC). Die Unterzeichner dieser Abkommen erkennen ihre Akkreditierungen gegenseitig an.

Der aktuelle Stand der Mitgliedschaft kann folgenden Webseiten entnommen werden:
EA: www.european-accreditation.org
ILAC: www.ilac.org
IAF: www.iaf.nu

Note:

The current certificate including annex is published on our website (see link below) or may be received from CETECOM ICT Services on request.

https://www.cetecom.com/en/cetecom-group/europe/germany-saarbruecken/accreditations.html